

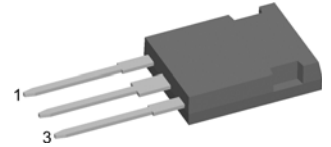
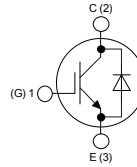
## XPT IGBT

Copack

$I_{C25} = 28 \text{ A}$   
 $V_{CES} = 1200 \text{ V}$   
 $V_{CE(sat)typ} = 1.8 \text{ V}$

Part number

IXA17IF1200HJ



### Features / Advantages:

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged XPT design (Xtreme light Punch Through) results in:
  - short circuit rated for 10  $\mu\text{sec}$ .
  - very low gate charge
  - low EMI
  - square RBSOA @ 3x  $I_c$
- Thin wafer technology combined with the XPT design results in a competitive low  $V_{CE(sat)}$
- SONIC™ diode
  - fast and soft reverse recovery
  - low operating forward voltage

### Applications:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies
- Inductive heating, cookers

### Package:

- Housing: ISOPLUS247
- Industry standard outline
- DCB isolated backside
- Isolation Voltage 3000 V
- Epoxy meets UL 94V-0
- RoHS compliant

## IGBT

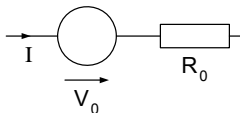
### Ratings

Symbol	Definition	Conditions	Ratings			Unit
			min.	typ.	max.	
$V_{CES}$	Collector emitter voltage	$V_{GE} = 0 \text{ V}$			1200	V
$V_{GES}$	Maximum DC gate voltage				$\pm 20$	V
$I_{C25}$	Collector current				28	A
$I_{C90}$					18	A
$P_{tot}$	Total power dissipation				100	W
$I_{CES}$	Collector emitter leakage current	$V_{CE} = V_{CES} ; V_{GE} = 0 \text{ V}$			0.1	mA
				0.1		mA
$I_{GES}$	Gate emitter leakage current	$V_{CE} = 0 \text{ V}; V_{GE} = \pm 20 \text{ V}$			500	nA
$V_{CE(sat)}$	Collector emitter saturation voltage	$I_C = 16 \text{ A}; V_{GE} = 15 \text{ V}$		1.8	2.1	V
				2.1		V
$V_{GE(th)}$	Gate emitter threshold voltage	$I_C = 0.6 \text{ mA}; V_{GE} = V_{CE}$	5.5	6	6.5	V
$Q_{Gon}$	Total gate charge	$V_{CE} = 600 \text{ V}; V_{GE} = 15 \text{ V}; I_C = 15 \text{ A}$		47		nC
$t_{d(on)}$	Turn-on delay time			70		ns
$t_r$	Current rise time			40		ns
$t_{d(off)}$	Turn-off delay time	Inductive load		250		ns
$t_f$	Current fall time	$V_{CE} = 600 \text{ V}; I_C = 15 \text{ A}$		100		ns
$E_{on}$	Turn-on energy per pulse	$V_{GE} = \pm 15 \text{ V}; R_G = 56 \Omega$	$T_{VJ} = 125^\circ\text{C}$	1.55		mJ
$E_{off}$	Turn-off energy per pulse			1.7		mJ
<b>RBSOA</b>	Reverse bias safe operation area	$V_{GE} = 15 \text{ V}; R_G = 56 \Omega$ $V_{CEK} = 1200 \text{ V}$	$T_{VJ} = 125^\circ\text{C}$		45	A
<b>SCSOA</b>	Short circuit safe operation area					
$t_{sc}$	Short circuit duration	$V_{CE} = 900 \text{ V}; V_{GE} = \pm 15 \text{ V}$	$T_{VJ} = 125^\circ\text{C}$		10	$\mu\text{s}$
$I_{sc}$	Short circuit current	$R_G = 56 \Omega$ ; non-repetitive			60	A
$R_{thJC}$	Thermal resistance junction to case				1.26	K/W

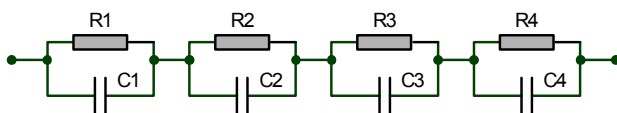
## Diode

Symbol	Definition	Conditions	Ratings			Unit
			min.	typ.	max.	
$I_{F25}$	Forward current	$T_C = 25^\circ\text{C}$			33	A
$I_{F90}$		$T_C = 90^\circ\text{C}$			20	A
$V_F$	Forward voltage	$I_F = 20\text{ A}$	$T_{VJ} = 25^\circ\text{C}$	1.95	2.2	V
			$T_{VJ} = 125^\circ\text{C}$	1.85		V
$Q_{rr}$	Reverse recovery charge	$V_R = 600\text{V};$ $di_F/dt = -\quad\quad\quad\text{A}/\mu\text{s};$ $I_F = 20\text{ A}$	$T_{VJ} = 125^\circ\text{C}$	tbd		$\mu\text{C}$
$I_{RM}$	Maximum reverse recovery current			tbd		A
$t_{rr}$	Reverse recovery time			tbd		ns
$E_{rec(off)}$	Reverse recovery losses at turn-off			tbd		mJ
$R_{thJC}$	Thermal resistance junction to case				1.5	K/W

## Equivalent Circuits for Simulation



Symbol	Definition		Ratings			Unit
			min.	typ.	max.	
$V_0$	IGBT	$T_{VJ} = 150^\circ\text{C}$			1.1	V
$R_0$					86	m $\Omega$
$V_0$	Diode	$T_{VJ} = 150^\circ\text{C}$			1.2	V
$R_0$					40	m $\Omega$



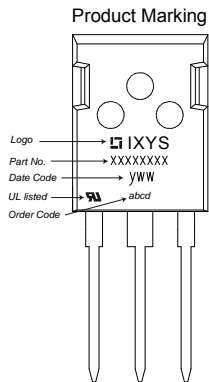
$$Z_{th}(t) = \sum_{i=1}^n \left[ R_i \cdot \left( 1 - \exp\left(-\frac{t}{\tau_i}\right) \right) \right]$$

$$\tau_i = R_i \cdot C_i$$

	IGBT	Diode
$R_1$	0.252	0.46
$R_2$	0.209	0.29
$R_3$	0.541	0.42
$R_4$	0.258	0.33
$\tau_1$	0.0015	0.0025
$\tau_2$	0.03	0.03
$\tau_3$	0.03	0.03
$\tau_4$	0.08	0.08

## Package ISOPLUS247

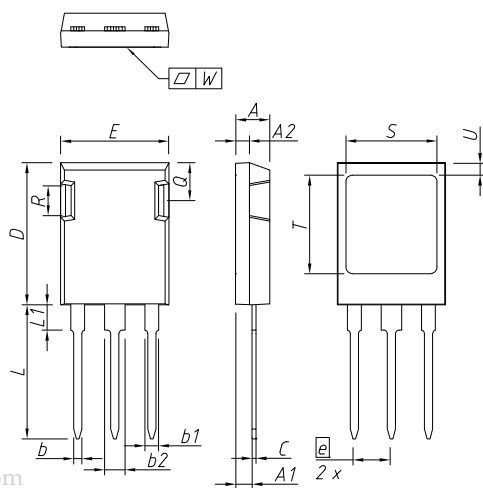
Symbol	Definition	Conditions	Ratings			Unit
			min.	typ.	max.	
$T_{vj}$	Virtual junction temperature		-55		150	°C
$T_{stg}$	Storage temperature		-55		150	°C
$R_{thCH}$	Thermal resistance case to heatsink			0.25		K/W
<b>Weight</b>				6		g
$F_C$	Mounting force with clip		20		120	N
$V_{ISOL}$	Isolation voltage	t = 1 second	3600			V
		t = 1 minute	3000			V
$d_s$	Creepage distance on surface					mm
$d_A$	Striking distance through air					mm



### Part number

I = IGBT  
 X = XPT IGBT  
 A = Gen 1 / std  
 17 = Current Rating [A]  
 IF = Copack  
 1200 = Reverse Voltage [V]  
 HJ = ISOPLUS247 (3)

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Code Key
Standard	IXA 17 IF 1200 HJ	IXA17IF1200HJ			



DIM.	MILLIMETER		INCHES	
	MIN	MAX	MIN	MAX
A	4,83	5,21	0,190	0,205
A1	2,29	2,54	0,090	0,100
A2	1,91	2,16	0,075	0,085
b	1,14	1,40	0,045	0,055
b1	1,91	2,15	0,075	0,085
b2	2,92	3,20	0,115	0,126
C	0,61	0,83	0,024	0,033
D	20,80	21,34	0,819	0,840
E	15,75	16,13	0,620	0,635
e	5,45 BSC		0,215 BSC	
L	19,81	20,60	0,780	0,811
L1	3,81	4,38	0,150	0,172
Q	5,59	6,20	0,220	0,244
R	4,32	4,85	0,170	0,191
S	13,21	13,72	0,520	0,540
T	15,75	16,26	0,620	0,640
U	1,65	2,03	0,065	0,080
W	-	0,10	-	0,004

Die konvexe Form des Substrates ist typ. < 0.04 mm über der Kunststoffoberfläche der Bauteilunterseite  
 The convex bow of substrate is typ. < 0.04 mm over plastic surface level of device bottom side

Die Gehäuseabmessungen entsprechen dem Typ TO-247 AD gemäß JEDEC außer Schraubloch und  $L_{max}$ .  
 This drawing will meet all dimensions requirement of JEDEC outline TO-247 AD except screw hole and except  $L_{max}$ .

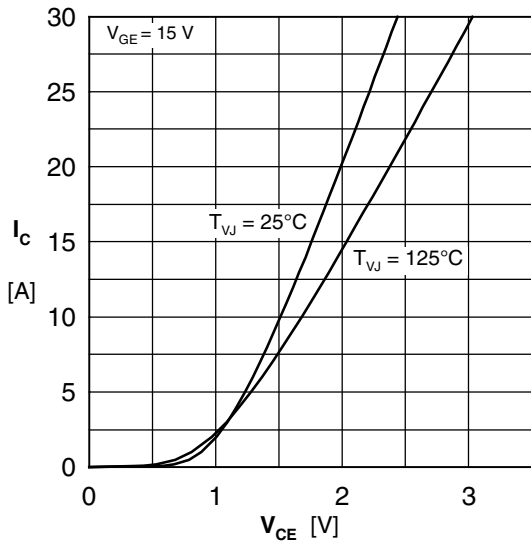


Fig. 1 Typ. output characteristics

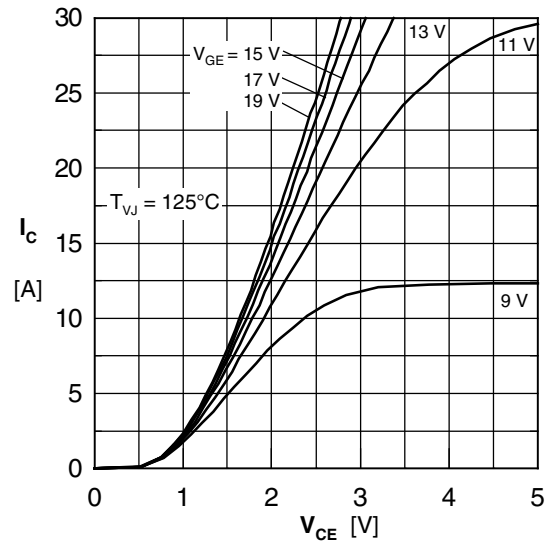


Fig. 2 Typ. output characteristics

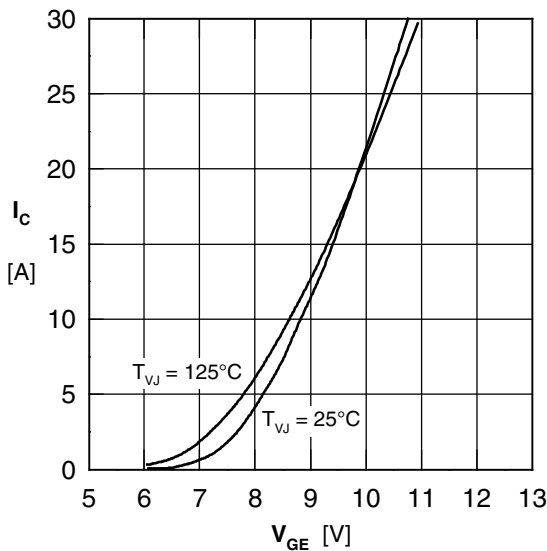


Fig. 3 Typ. transfer characteristics

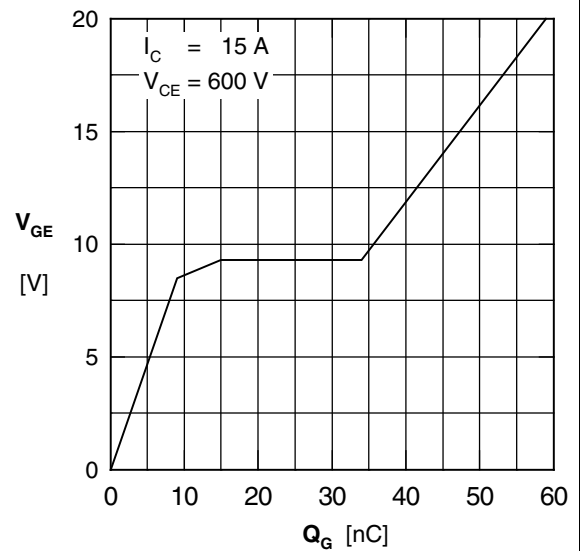


Fig. 4 Typ. turn-on gate charge

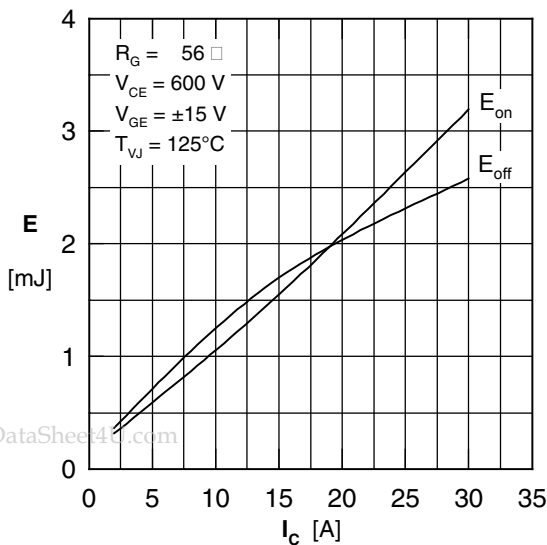


Fig. 5 Typ. switching energy vs. collector current

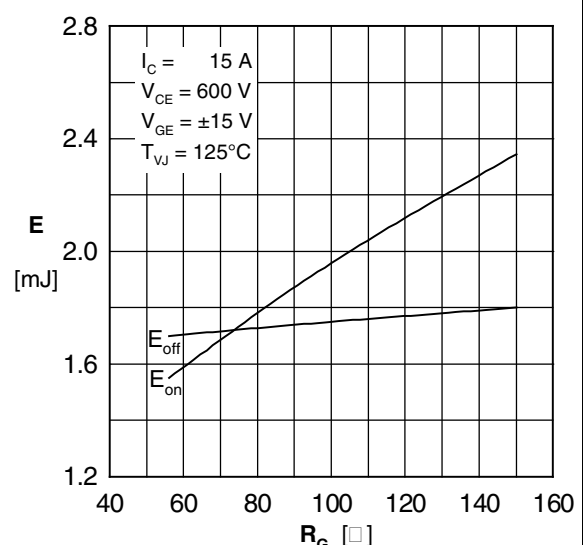


Fig. 6 Typ. switching energy vs. gate resistance

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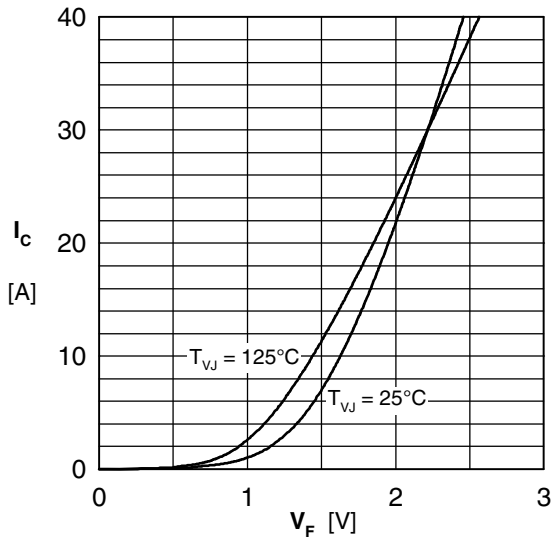


Fig. 7 Typ. forward characteristic

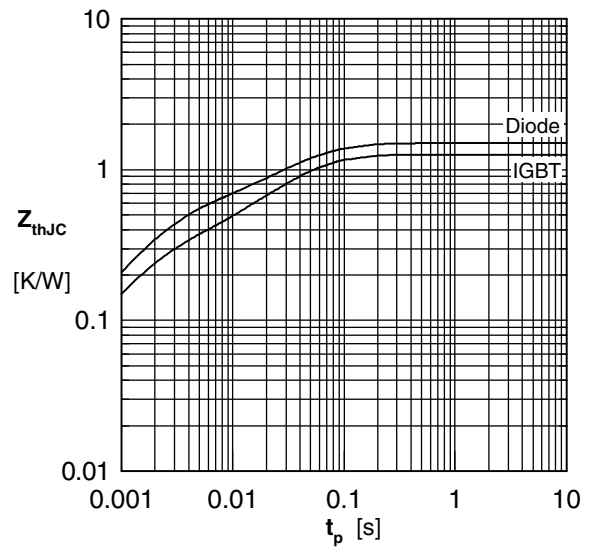


Fig. 8 Typ. transient thermal impedance